



Features

P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary (Typ. @ V_{GS} = -4.5V, T_A = +25°C)

ſ	V _{DSS}	R _{DS(on)}	Qg	Q_{gd}	ID
	-8V	8.2mΩ	8.1nC	1.8nC	-10A

Description

This 3^{rd} generation Lateral MOSFET (LD-MOS) is engineered to minimize on-state losses and switch ultra-fast, making it ideal for high-efficiency power transfer. It uses Chip-Scale Package (CSP) to increase power density by combining low thermal impedance with minimal R_{DS(on)} per footprint area.

Applications

- DC-DC Converters
- Battery Management
- Load Switch

LD-MOS Technology with the Lowest Figure of Merit: $-R_{DS(on)} = 8.2m\Omega$ to Minimize On-State Losses

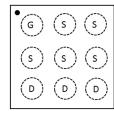
- -Q_g = 8.1nC for Ultra-Fast Switching V_{gs(th)} = -0.8V typ. for a Low Turn-On Potential
- CSP with Footprint 1.5mm × 1.5mm
- Height = 0.60mm for Low Profile
- ESD = 6kV HBM Protection of Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

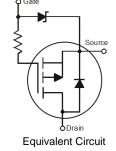
- Case: U-WLB1515-9
- Terminal Connections: See Diagram Below

U-WLB1515-9





Top-View Pin Configuration



Ordering Information (Note 4)

Part Number	Case	Packaging		
DMP1011UCB9-7	U-WLB1515-9	3,000/Tape & Reel		

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

 See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information

U-WLB1515-9



NX = Product Type Marking Code YM = Date Code Marking Y or \overline{Y} = Year (ex: B = 2014) M or \overline{M} = Month (ex: 9 = September)

Date Code Key

Notes:

Date Code Rey													
Year	Year 2012 2013			2014 2015		2016		2017	2	2018			
Code	Z		А		В	(С			Е		F	
Month	Jan	Feb	Mar	Apr	Мау	Jun	Jul	Aug	Sep	Oct	Nov	Dec	
Code	1	2	3	4	5	6	7	8	9	0	N	D	



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Drain-Source Voltage		V _{DSS}	-8	V
Gate-Source Voltage		V _{GSS}	-6	V
Continuous Drain Current (Note 5) V_{GS} = -4.5V	T _A = +25°C T _A = +70°C	ID	-10 -8	A
Continuous Drain Current (Note 6) V_{GS} = -4.5V	Steady State	ID	-7.4 -6.0	A
Pulsed Drain Current (Pulse duration 10µs, duty cy	/cle ≤1%)	I _{DM}	-50	A
Continuous Source Pin Current (Note 6)		ls	-2	_
Pulsed Source Pin Current (Pulse duration 10µs, c	luty cycle ≤	lsм	-15	—
Continuous Gate Current		I _G	-0.5	A

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units
Total Power Dissipation (Note 5)	PD	0.89	W
Total Power Dissipation (Note 6)	PD	1.57	W
Thermal Resistance, Junction to Ambient (Note 5)	R _{0JA}	+142.1	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	R _{0JA}	+80.5	°C/W
Operating and Storage Temperature Range	T _{J,} T _{STG}	-55 to +150	O°

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Cumple of	Min	T. m	Max	11	Test Condition	
Characteristic OFF CHARACTERISTICS (Note 7)	Symbol	Min	Тур	Max	Unit	Test Condition	
	BV _{DSS}	-8	_	_	V	V(0)(1 050)	
Drain-Source Breakdown Voltage		-8 -6			V	$V_{GS} = 0V, I_D = -250\mu A$	
Gate to Source Voltage	BV _{SGS}	-				$V_{DS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current $@T_C = +25^{\circ}C$	IDSS	_		-1	μA	$V_{DS} = -4.0V, V_{GS} = 0V$	
Gate-Source Leakage	Igss	_	_	-100	nA	$V_{GS} = -4.0V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V _{GS(th)}	-0.4	-0.8	-1.1	V	$V_{DS} = V_{GS}, I_D = -250 \mu A$	
			8.2	10		$V_{GS} = -4.5V, I_D = -2A$	
Static Drain-Source On-Resistance	R _{DS (ON)}	—	10	13	mΩ	$V_{GS} = -3.0V, I_D = -2A$	
			11	14		$V_{GS} = -2.5V, I_D = -2A$	
Forward Transfer Admittance	Y _{fs}		16.8	_	S	$V_{DS} = -4V, I_{D} = -2A$	
Diode Forward Voltage (Note 6)	V _{SD}	_	-0.7	-1	V	$V_{GS} = 0V, I_{S} = -2A$	
Reverse Recovery Charge	Qrr	_	6.3	-	nC	$V_{dd} = -5V, I_F = -2A,$	
Reverse Recovery Time	t _{rr}	_	18.5		ns	di/dt = 200A/µs	
DYNAMIC CHARACTERISTICS (Note 8)						-	
Input Capacitance	Ciss	—	817	1,060	pF		
Output Capacitance	Coss	_	595	770	pF	V _{DS} = -4V, V _{GS} = 0V, f = 1.0MHz	
Reverse Transfer Capacitance	Crss	—	269	350	pF	1 = 1.000112	
Series Gate Resistance	R _G	_	1.9		Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge (4.5V)	Qq	—	8.1	10.5	nC		
Gate-Source Charge	Q _{gs}	_	0.9		nC	$V_{GS} = -4.5V, V_{DS} = -4V,$	
Gate-Drain Charge	Q _{gd}	_	1.8	_	nC	$I_D = -2A$	
Turn-On Delay Time	t _{D(on)}	_	6.2	10	ns		
Turn-On Rise Time	tr		22.6	—	ns	$V_{DD} = -4V, V_{GS} = -4.5V,$	
Turn-Off Delay Time	t _{D(off)}	_	30.1	48	ns	$I_{DS} = -2A, R_G = 10\Omega,$	
Turn-Off Fall Time	tf		22.7	_	ns	1	

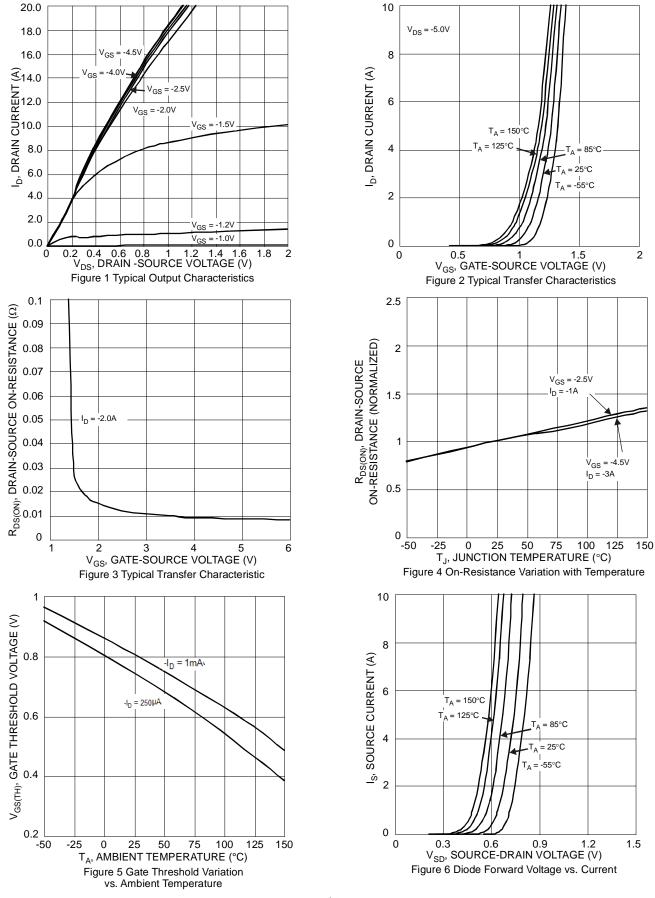
Notes: 5. Device mounted on FR-4 PCB with minimum recommended pad layout.

6. Device mounted on FR4 material with 1-inch² (6.45cm²), 2oz (0.071mm thick) Cu.

7. Short duration pulse test used to minimize self-heating effect.
8. Guaranteed by design. Not subject to production testing.

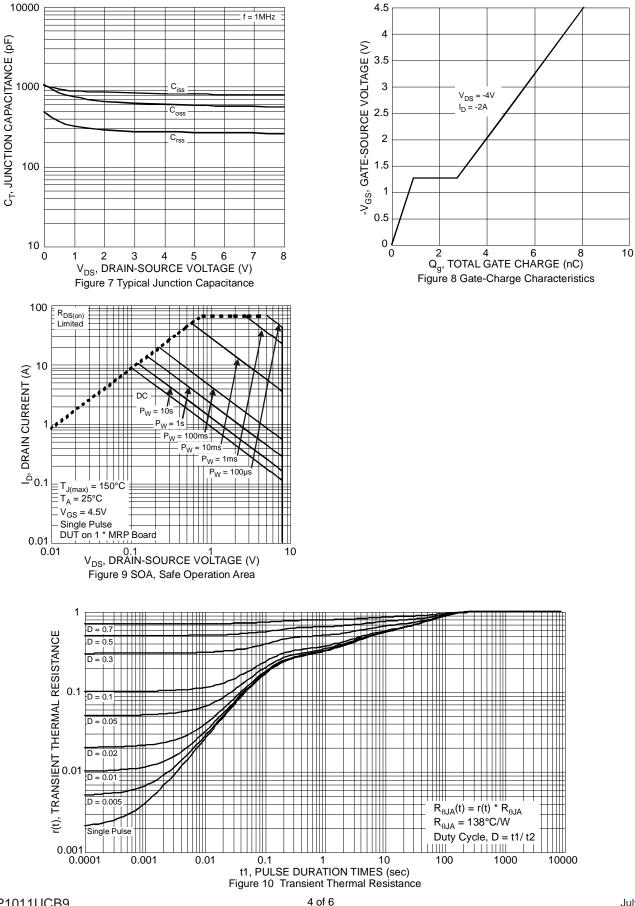
DMP1011UCB9





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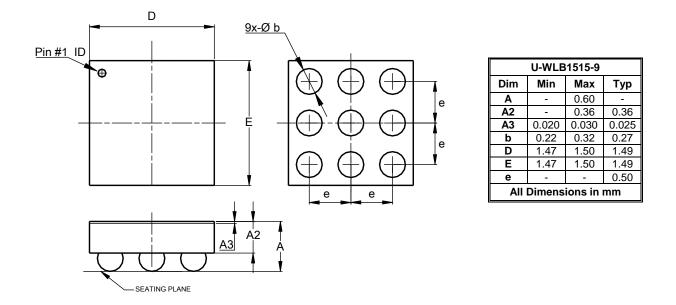






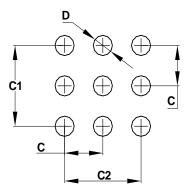
Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)				
С	0.50				
C1	1.00				
C2	1.00				
D	0.25				



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